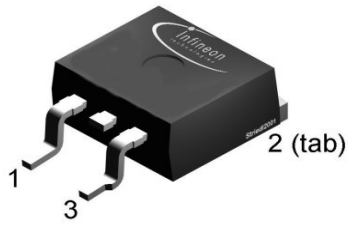
MOSFET

OptiMOS™ 5 Linear FET, 150 V

D²PAK



Features

- Ideal for hot-swap and e-fuse applications
- Very low on-resistance $R_{DS(on)}$
- Wide safe operating area SOA
- N-channel, normal level
- 100% avalanche tested
- Pb-free plating; RoHS compliant
- Qualified according to JEDEC[1)] for target applications
- Halogen-free according to IEC61249-2-21

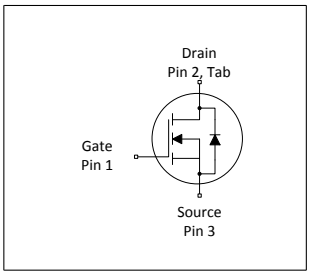


Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS}	150	V
$R_{DS(on),max}$	4.8	mΩ
I_D (silicon limited)	182	A
I_D (package limited)	120	A
I_{pulse} (V_{DS}=56 V, t_p=10 ms)	10.8	A

Type / Ordering Code	Package	Marking	Related Links
IPB048N15N5LF	PG-TO 263-3	048N15LF	-

[1)] J-STD20 and JESD22

Table of Contents

1 Maximum ratings

at T_C=25 °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current	I_D	- - -	- - -	120 115 18	A	V_{GS}=10 V, T_C=25 °C V_{GS}=10 V, T_C=100 °C V_{GS}=10 V, T_C=25 °C, R_{thJA} =40 K/W[1)]
Pulsed drain current[2)]	$I_{D,pulse}$	-	-	480	A	T_C=25 °C
Avalanche energy, single pulse[3)]	E_{AS}	-	-	30	mJ	I_D=40 A, R_{GS}=25 Ω
Gate source voltage	V_{GS}	-20	-	20	V	-
Power dissipation	P_{tot}	-	-	313	W	T_C=25 °C
Operating and storage temperature	T_j, T_{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	0.25	0.4	K/W	-
Device on PCB, minimal footprint	R_{thJA}	-	-	62	K/W	-
Device on PCB, 6 cm² cooling area[1)]	R_{thJA}	-	-	40	K/W	-

[1)] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.
[2)] See Diagram 3 for more detailed information
[3)] See Diagram 13 for more detailed information

3 Electrical characteristics

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	150	-	-	V	V_{GS}=0 V, I_D=1 mA
Gate threshold voltage	$V_{GS(th)}$	3.3	4.1	4.9	V	V_{DS}=V_{GS}, I_D=255 µA
Zero gate voltage drain current	I_{DSS}	- -	1 10	2 100	µA	V_{DS}=120 V, V_{GS}=0 V, T_j=25 °C V_{DS}=120 V, V_{GS}=0 V, T_j=125 °C
Gate-source leakage current	I_{GSS}	- -	2 -2	5 -5	µA	V_{GS}=20 V, V_{DS}=0 V V_{GS}=-10 V, V_{DS}=0 V
Drain-source on-state resistance	$R_{DS(on)}$	-	3.9	4.8	mΩ	V_{GS}=10 V, I_D=100 A
Gate resistance[1)]	R_G	-	25	38	Ω	-
Transconductance	g_{fs}	17	34	-	S	|V_{DS}|>2|I_D|$R_{DS(on)max}$, I_D=100 A

Table 5 Dynamic characteristics[1)]

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	290	380	pF	V_{GS}=0 V, V_{DS}=75 V, f=1 MHz
Output capacitance	C_{oss}	-	1400	1800	pF	V_{GS}=0 V, V_{DS}=75 V, f=1 MHz
Reverse transfer capacitance	C_{rss}	-	13	23	pF	V_{GS}=0 V, V_{DS}=75 V, f=1 MHz
Turn-on delay time	$t_{d(on)}$	-	8	-	ns	V_{DD}=75 V, V_{GS}=10 V, I_D=60 A, $R_{G,ext}$=1.6 Ω
Rise time	t_r	-	48	-	ns	V_{DD}=75 V, V_{GS}=10 V, I_D=60 A, $R_{G,ext}$=1.6 Ω
Turn-off delay time	$t_{d(off)}$	-	42	-	ns	V_{DD}=75 V, V_{GS}=10 V, I_D=60 A, $R_{G,ext}$=1.6 Ω
Fall time	t_f	-	10	-	ns	V_{DD}=75 V, V_{GS}=10 V, I_D=60 A, $R_{G,ext}$=1.6 Ω

Table 6 Gate charge characteristics[2)]

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	2	-	nC	V_{DD}=75 V, I_D=60 A, V_{GS}=0 to 10 V
Gate to drain charge[1)]	Q_{gd}	-	56	-	nC	V_{DD}=75 V, I_D=60 A, V_{GS}=0 to 10 V
Gate charge total[1)]	Q_g	-	84	-	nC	V_{DD}=75 V, I_D=60 A, V_{GS}=0 to 10 V
Gate plateau voltage	$V_{plateau}$	-	7	-	V	V_{DD}=75 V, I_D=60 A, V_{GS}=0 to 10 V
Output charge[1)]	Q_{oss}	-	211	280	nC	V_{DD}=75 V, V_{GS}=0 V

[1)] Defined by design. Not subject to production test.
[2)] See "Gate charge waveforms" for parameter definition

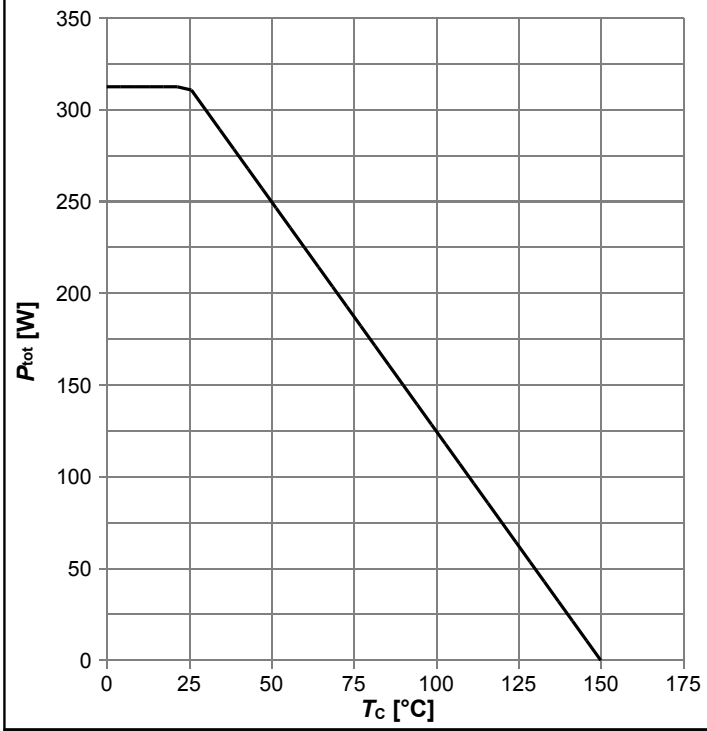
Table 7 Reverse diode

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_S	-	-	120	A	T_C=25 °C
Diode pulse current	$I_{S,pulse}$	-	-	480	A	T_C=25 °C
Diode forward voltage	V_{SD}	-	0.93	1.2	V	V_{GS}=0 V, I_F=100 A, T_j=25 °C
Reverse recovery time[1)]	t_{rr}	-	60	-	ns	V_R=75 V, I_F=60 A, di_F/dt=100 A/µs
Reverse recovery charge[1)]	Q_{rr}	-	81	-	nC	V_R=75 V, I_F=60 A, di_F/dt=100 A/µs

[1)] Defined by design. Not subject to production test.

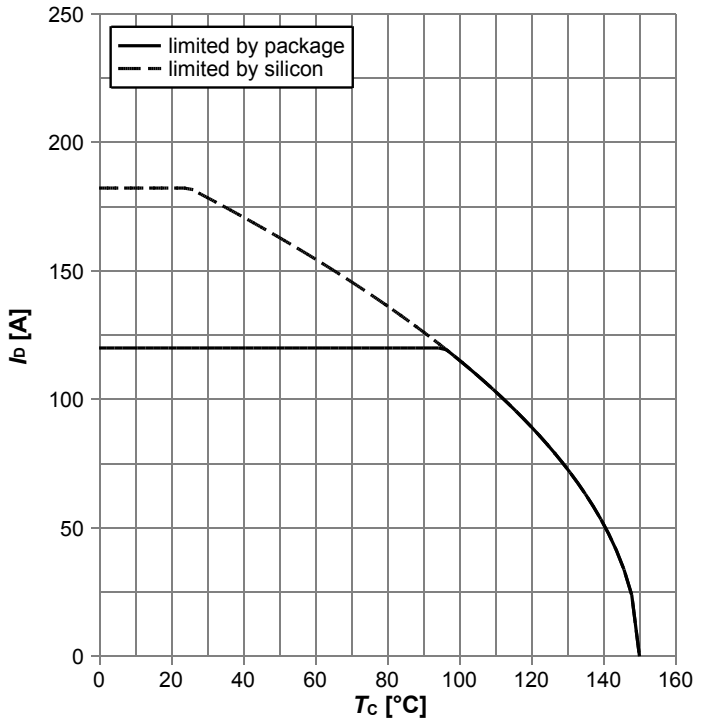
4 Electrical characteristics diagrams

Diagram 1: Power dissipation



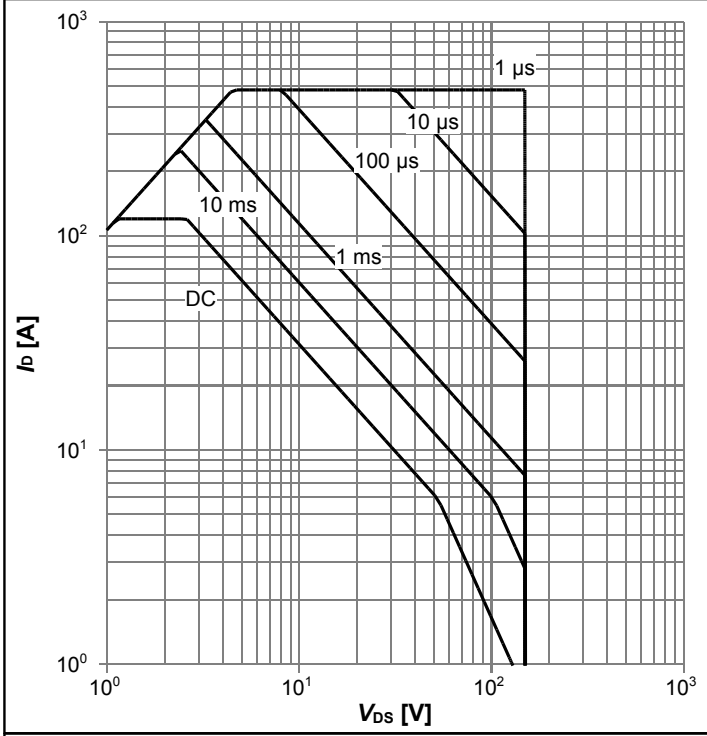
$P_{tot}=f(T_C)$

Diagram 2: Drain current



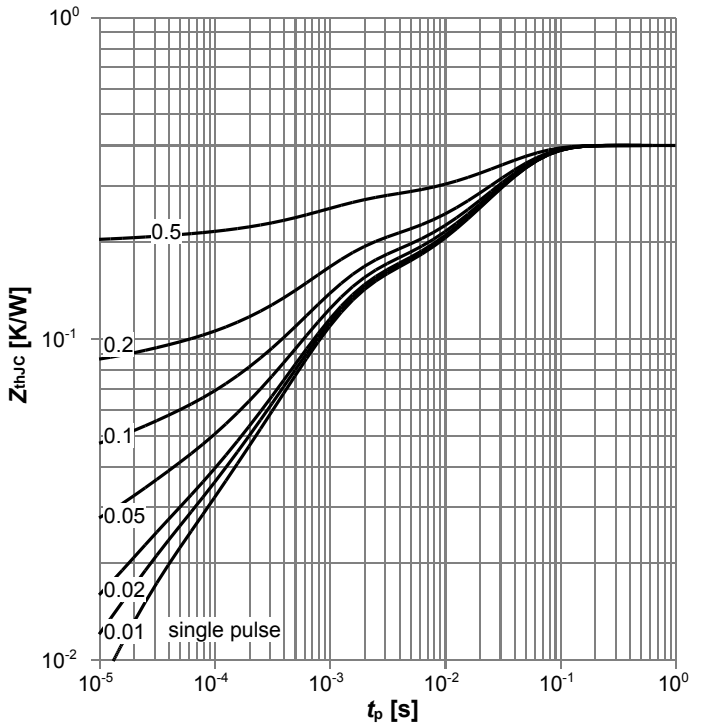
$I_D=f(T_C)$; $V_{GS}\geq 10$ V

Diagram 3: Safe operating area



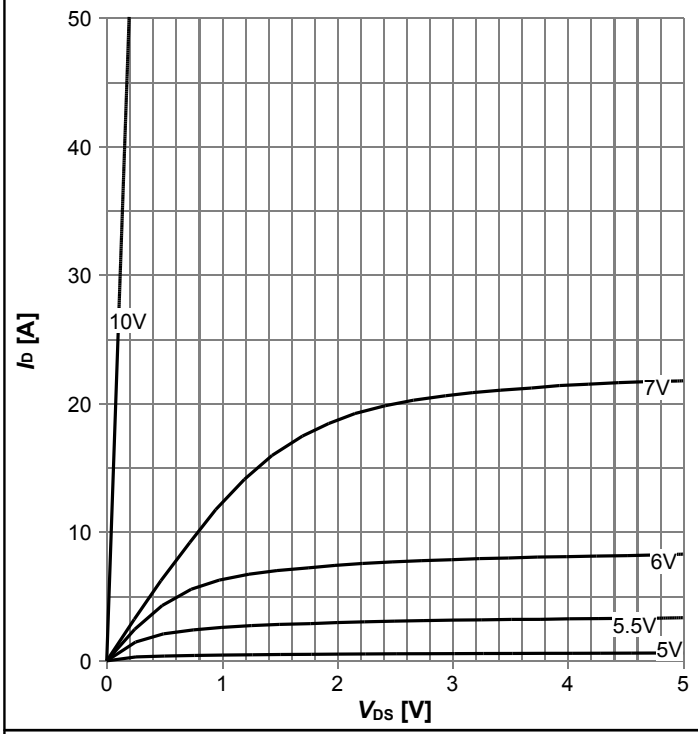
$I_D=f(V_{DS})$; T_C=25 °C; D=0; parameter: t_p

Diagram 4: Max. transient thermal impedance



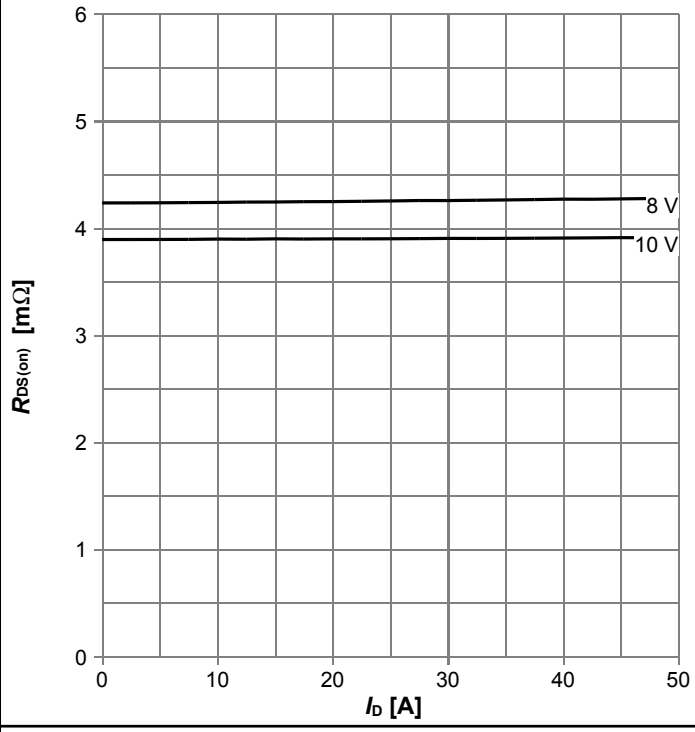
$Z_{thJC}=f(t_p)$; parameter: $D=t_p/T$

Diagram 5: Typ. output characteristics



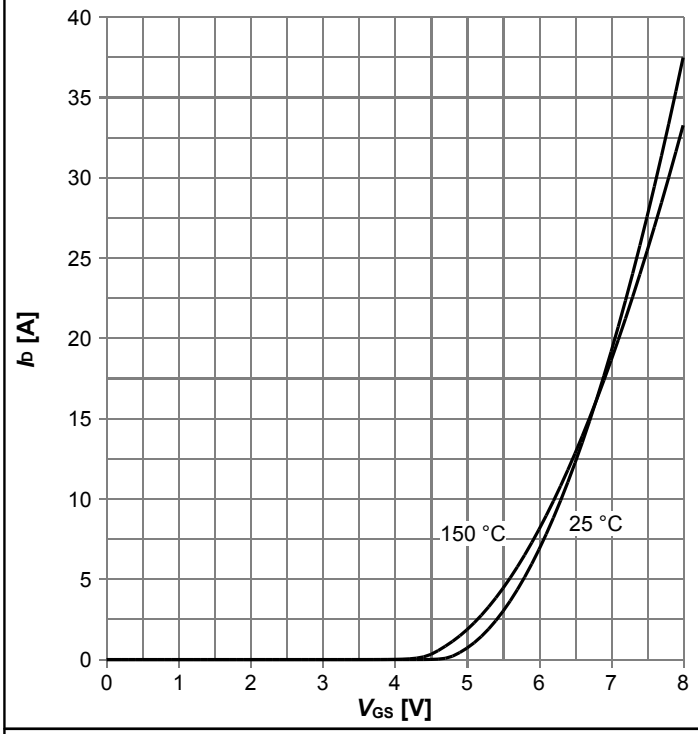
$I_D=f(V_{DS})$, $T_j=25$ °C; parameter: V_{GS}

Diagram 6: Typ. drain-source on resistance



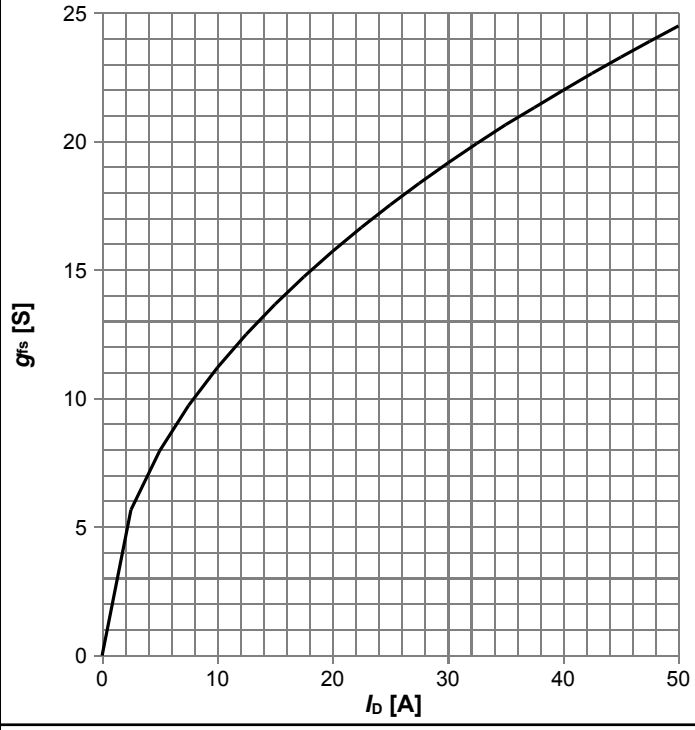
$R_{DS(on)}=f(I_D)$, $T_j=25$ °C; parameter: V_{GS}

Diagram 7: Typ. transfer characteristics



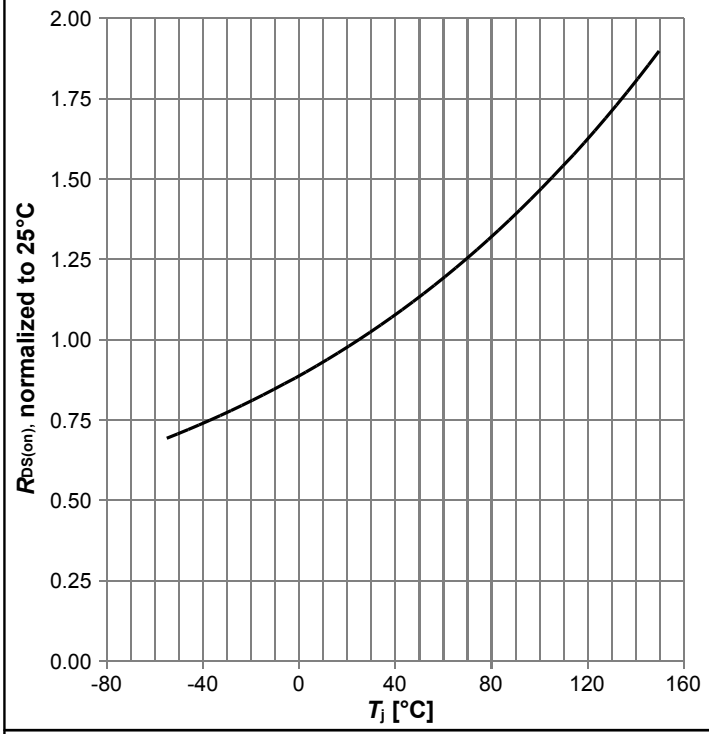
$I_D=f(V_{GS})$, $|V_{DS}|>2|I_D|R_{DS(on)max}$; parameter: T_j

Diagram 8: Typ. forward transconductance



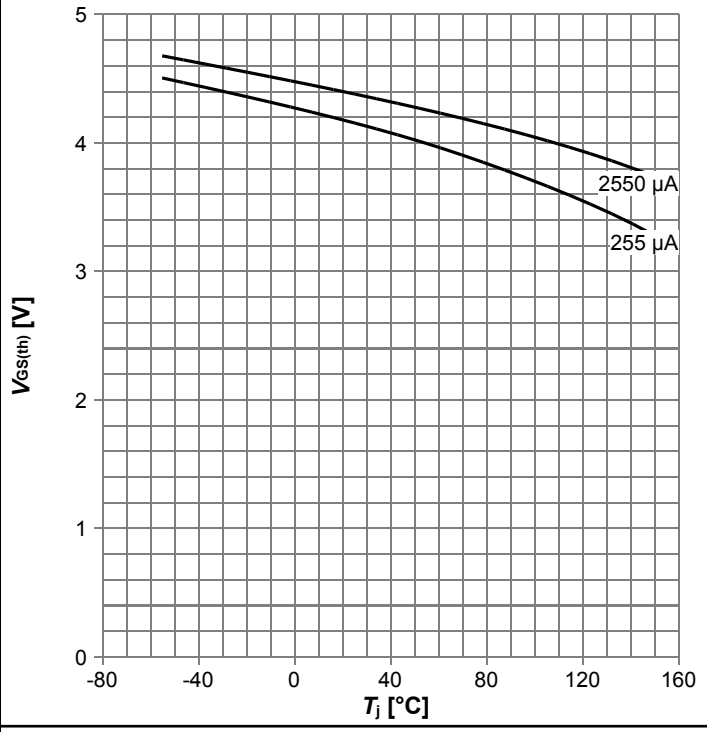
$g_{fs}=f(I_D)$, $V_{DS}=5$ V, $T_j=25$ °C

Diagram 9: Normalized drain-source on-state resistance



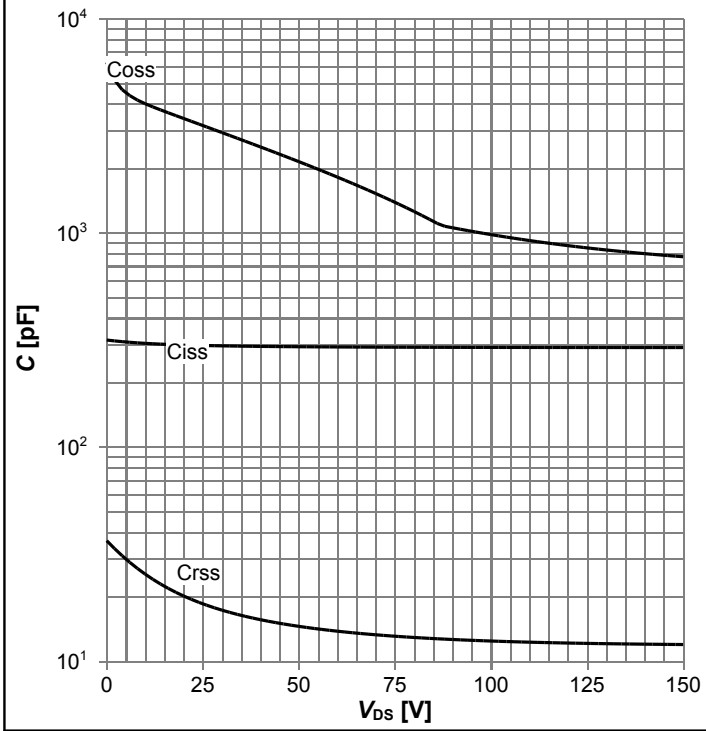
$R_{DS(on)}$=f(T_j), I_D=100 A, V_{GS}=10 V

Diagram 10: Typ. gate threshold voltage



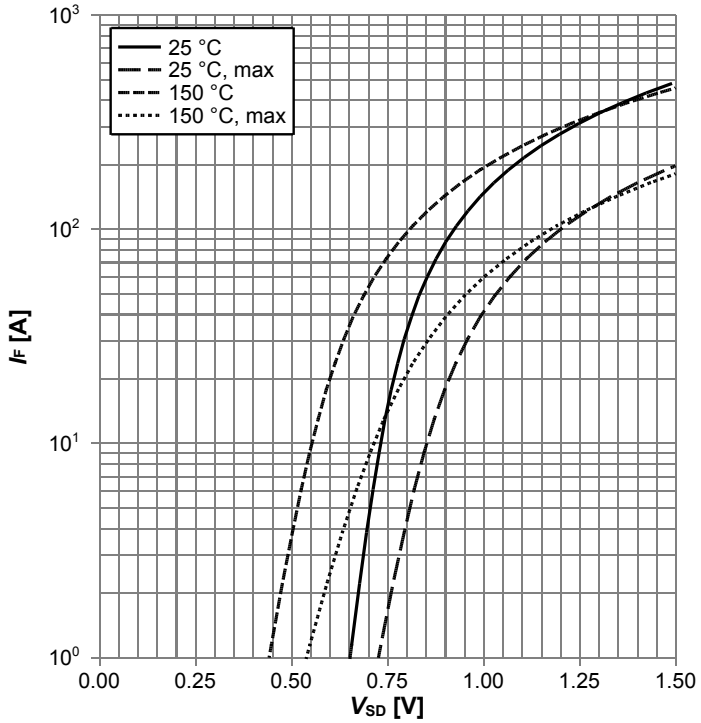
$V_{GS(th}$=f(T_j), V_{GS}=V_{DS}; parameter: I_D

Diagram 11: Typ. capacitances



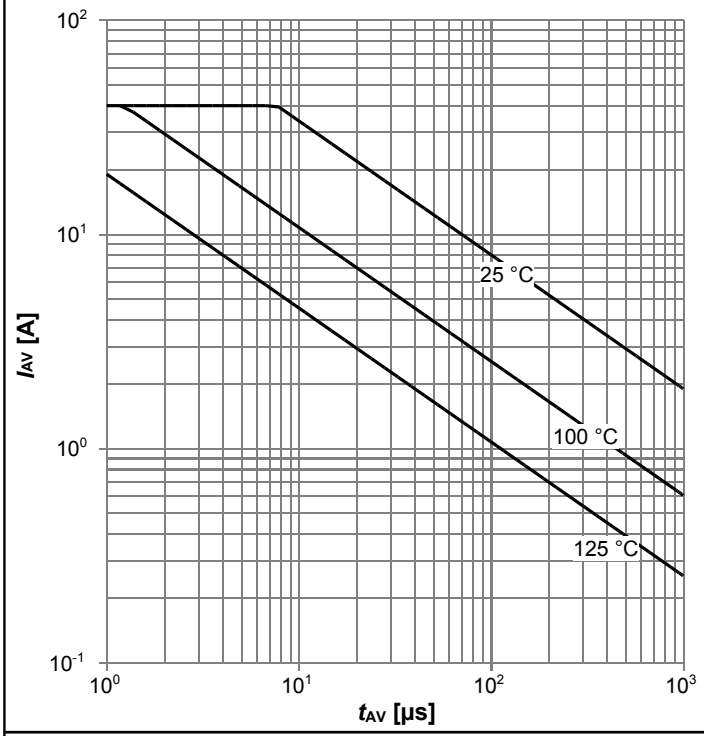
C=f(V_{DS}); V_{GS}=0 V; f=1 MHz

Diagram 12: Forward characteristics of reverse diode



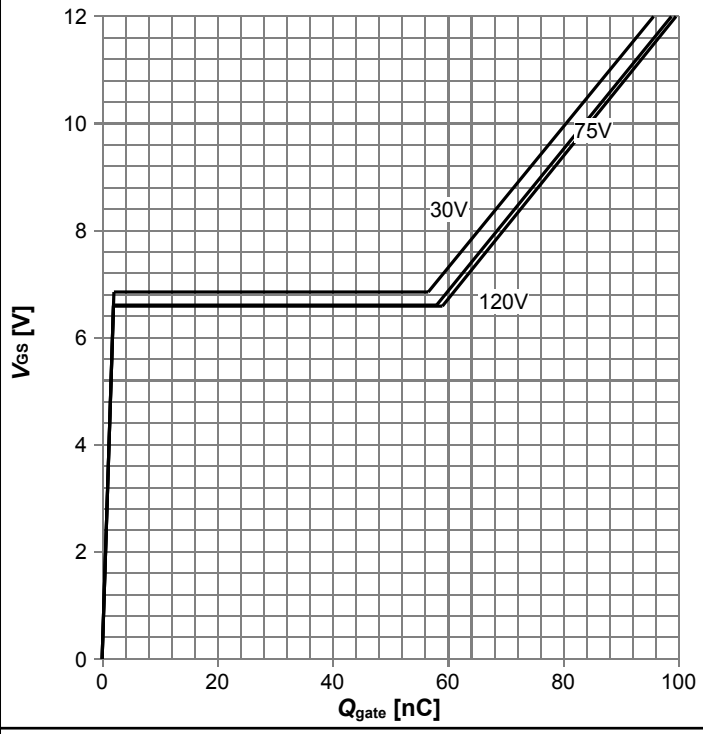
I_F=f(V_{SD}); parameter: T_j

Diagram 13: Avalanche characteristics



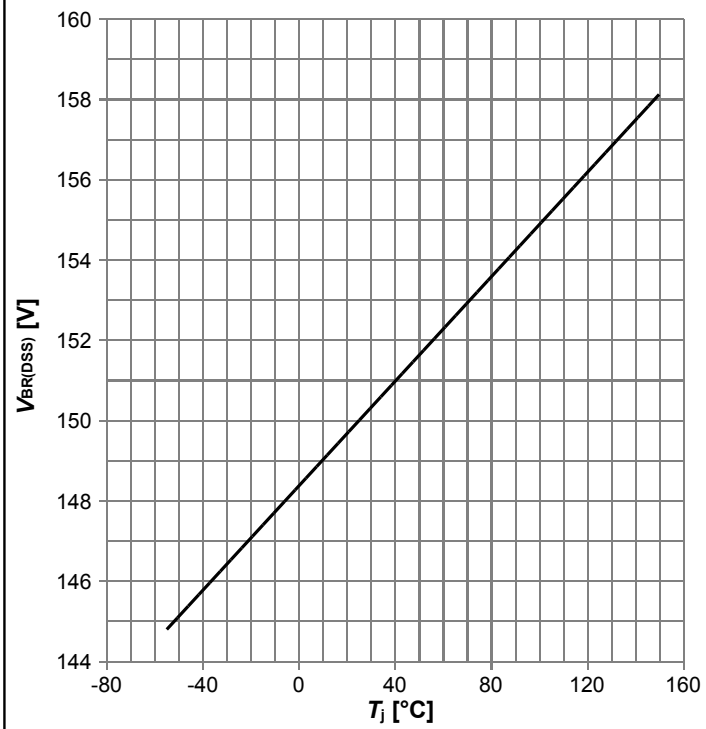
$I_{AS}=f(t_{AV})$; $R_{GS}=25\ \Omega$; parameter: $T_{j,start}$

Diagram 14: Typ. gate charge



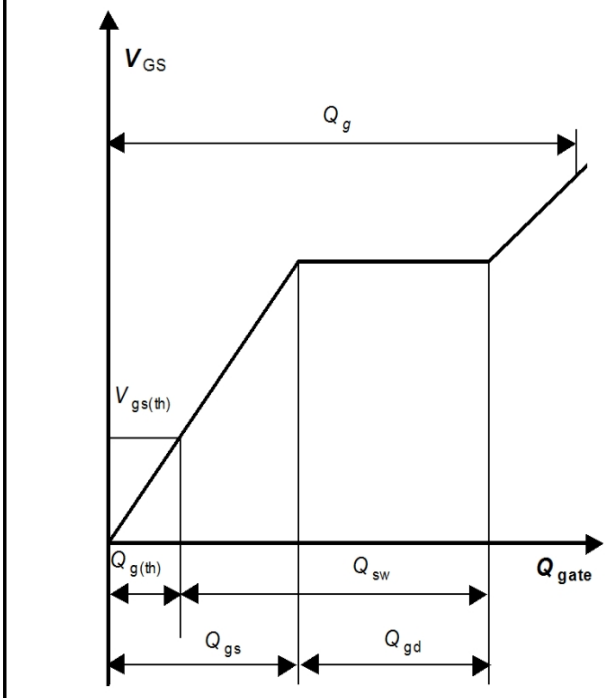
$V_{GS}=f(Q_{gate})$; $I_D=60$ A pulsed, resistive load; parameter: V_{DD}

Diagram 15: Drain-source breakdown voltage

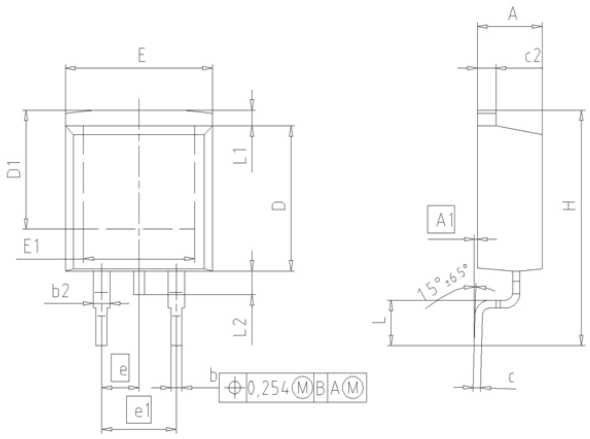


$V_{BR(DSS)}=f(T_j)$; $I_D=1$ mA

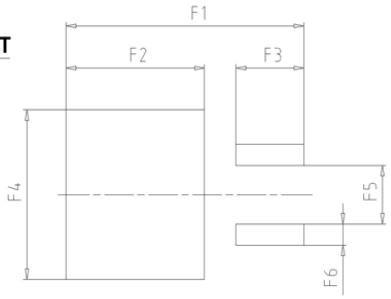
Gate charge waveforms



5 Package Outlines



FOOTPRINT



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	0.00	0.25	0.000	0.010
b	0.65	0.85	0.026	0.033
b2	0.95	1.15	0.037	0.045
c	0.33	0.65	0.013	0.026
c2	1.17	1.40	0.046	0.055
D	8.51	9.45	0.335	0.372
D1	7.10	7.90	0.280	0.311
E	9.80	10.31	0.386	0.406
E1	6.50	8.60	0.256	0.339
e	2.54		0.100	
e1	5.08		0.200	
N	2		2	
H	14.61	15.88	0.575	0.625
L	2.29	3.00	0.090	0.118
L1	0.70	1.60	0.028	0.063
L2	1.00	1.78	0.039	0.070
F1	16.05	16.25	0.632	0.640
F2	9.30	9.50	0.366	0.374
F3	4.50	4.70	0.177	0.185
F4	10.70	10.90	0.421	0.429
F5	3.65	3.85	0.144	0.152
F6	1.25	1.45	0.049	0.057

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SCALE
0 5 5
7.5mm

EUROPEAN PROJECTION

ISSUE DATE
30-08-2007

REVISION
01

Figure 1 Outline PG-TO 263-3, dimensions in mm/inches

Revision History

IPB048N15N5LF

Revision: 2017-03-29, Rev. 2.0

Previous Revision		
Revision	Date	Subjects (major changes since last revision)
2.0	2017-03-29	Release of final version

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